## Search Notes



Application/Control	No.

Applicant(s)/Patent Under Reexamination 10585642 YANO ET AL.

Examiner

Rachel L Burney

Art Unit 1795

## SEARCHED

Class	Subclass	Date	Examiner		
430	48, 108.2	6/3/2010	RLB		
528	361	6/3/2010	RLB		
399	130, 50	6/3/2010	RLB		
430	111.32, 111.35	12/01/2010	RLZ		

## **SEARCH NOTES**

Search Notes	Date	Examiner
inventorship search	6/3/2010	RLB
text searc in EAST (see search history)h	6/3/2010	RLB
consulted with SPE Mark Huff	6/3/2010	RLB
updated text search in EAST (see search history)	12/01/2010	RLZ
consulted with Chris RoDee	12/01/2010	RLZ

INTERFERENCE SEARCH				
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